



SLLS533B - MAY 2002 - REVISED MAY 2003

## HIGH OUTPUT RS-485 TRANSCEIVERS

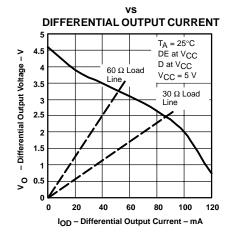
#### **FEATURES**

- Minimum Differential Output Voltage of 2.5 V Into a 54-Ω Load
- Open-Circuit, Short-Circuit, and Idle-Bus Failsafe Receiver
- 1/8<sup>th</sup> Unit-Load Option Available (Up to 256 Nodes on the Bus)
- Bus-Pin ESD Protection Exceeds 16 kV HBM
- Driver Output Slew Rate Control Options
- Electrically Compatible With ANSI TIA/EIA-485-A Standard
- Low-Current Standby Mode . . . 1 μA Typical
- Glitch-Free Power-Up and Power-Down Protection for Hot-Plugging Applications
- Pin Compatible With Industry Standard SN75176

#### **APPLICATIONS**

- Data Transmission Over Long or Lossy Lines or Electrically Noisy Environments
- Profibus Line Interface
- Industrial Process Control Networks
- Point-of-Sale (POS) Networks
- Electric Utility Metering
- Building Automation
- Digital Motor Control

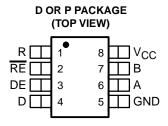
#### **DIFFERENTIAL OUTPUT VOLTAGE**

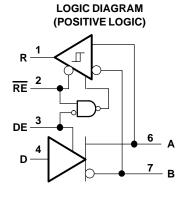


#### DESCRIPTION

SN65HVD05, SN75HVD05, SN65HVD06, SN75HVD06, SN65HVD07, and SN75HVD07 combine a 3-state differential line driver and differential line receiver. They are designed for balanced data transmission and interoperate with TIA/EIA-485-A and ISO 8482E standard-compliant devices. The driver is designed to provide a differential output voltage greater than that required by these standards for increased noise margin. The drivers and receivers have active-high and active-low enables respectively, which can be externally connected together to function as direction control.

The driver differential outputs and receiver differential inputs connect internally to form a differential input/output (I/O) bus port that is designed to offer minimum loading to the bus whenever the driver is disabled or not powered. These devices feature wide positive and negative common-mode voltage ranges, making them suitable for party-line applications.







Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

#### ORDERING INFORMATION(1)

							(ED AS
SIGNALING RATE	UNIT LOAD	DRIVER OUTPUT SLOPE CONTROL	TA	PART NUMBER(2)		PLASTIC DUAL-IN-LINE PACKAGE (PDIP)	SMALL OUTLINE IC (SOIC) PACKAGE
40 Mbps	1/2	No		SN65HVD05D	SN65HVD05P	65HVD05	VP05
10 Mbps	1/8	Yes	–40°C to 85°C	SN65HVD06D	SN65HVD06P	65HVD06	VP06
1 Mbps	1/8	Yes		SN65HVD07D	SN65HVD07P	65HVD07	VP07
40 Mbps	1/2	No		SN75HVD05D	SN75HVD05P	75HVD05	VN05
10 Mbps	1/8	Yes	−0°C to 70°C	SN75HVD06D	SN75HVD06P	75HVD06	VN06
1 Mbps	1/8	Yes		SN75HVD07D	SN75HVD07P	75HVD07	VN07

<sup>(1)</sup> For the most current specification and package information, refer to our web site at www.ti.com.

#### PACKAGE DISSIPATION RATINGS (SEE FIGURE 12 AND FIGURE 13)

PACKAGE	T <sub>A</sub> ≤ 25°C POWER RATING	DERATING FACTOR <sup>(1)</sup> ABOVE T <sub>A</sub> = 25°C	T <sub>A</sub> = 70°C POWER RATING	T <sub>A</sub> = 85°C POWER RATING
D(2)	710 mW	5.7 mW/°C	455 mW	369 mW
D(3)	1282 mW	10.3 mW/°C	821 mW	667 mW
Р	1000 mW	8.0 mW/°C	640 mW	520 mW

<sup>(1)</sup> This is the inverse of the junction-to-ambient thermal resistance when board-mounted and with no air flow.

#### ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range unless otherwise noted(1) (2)

			SN65HVD05, SN65HVD06, SN65HVD07 SN75HVD05, SN75HVD06, SN75HVD07
Supply voltage range, VC	CC		−0.3 V to 6 V
Voltage range at A or B			−9 V to 14 V
Input voltage range at D,	DE, R or RE		-0.5 V to V <sub>CC</sub> + 0.5 V
Voltage input range, transient pulse, A and B, through 100 $\Omega$ (see Figure 11)			−50 V to 50 V
	Human body model(3)	A, B, and GND	16 kV
Electrostatic discharge		All pins	4 kV
	Charged-device model <sup>(4)</sup>	All pins	1 kV
Continuous total power dissipation			See Dissipation Rating Table
Storage temperature range, T <sub>Stg</sub>		−65°C to 150°C	
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds			260°C

<sup>(1)</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

<sup>(2)</sup> The D package is available taped and reeled. Add an R suffix to the device type (i.e., SN65HVD05DR).

<sup>(2)</sup> Tested in accordance with the Low-K thermal metric definitions of EIA/JESD51-3

<sup>(3)</sup> Tested in accordance with the High-K thermal metric definitions of EIA/JESD51-7

<sup>(2)</sup> All voltage values, except differential I/O bus voltages, are with respect to network ground terminal.

<sup>(3)</sup> Tested in accordance with JEDEC Standard 22, Test Method A114-A.

<sup>(4)</sup> Tested in accordance with JEDEC Standard 22, Test Method C101.



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#### **RECOMMENDED OPERATING CONDITIONS**

		MIN	NOM MAX	UNIT
Supply voltage, V <sub>CC</sub>		4.5	5.5	V
Voltage at any bus terminal (separately or c	ommon mode) V <sub>I</sub> or V <sub>I</sub> C	<sub>-7</sub> (1)	12	V
High-level input voltage, VIH	D, DE, RE	2		V
Low-level input voltage, V <sub>IL</sub>	D, DE, RE		0.8	V
Differential input voltage, VID (see Figure 7	)	-12	12	V
High-level output current, IOH	Driver	-100		
	Receiver	-8		mA
	Driver		100	
Low-level output current, IOL	Receiver		8	mA
	SN65HVD05			
	SN65HVD06	-40	85	°C
	SN65HVD07			
Operating free-air temperature, T <sub>A</sub>	SN75HVD05			
	SN75HVD06	0	70	°C
	SN75HVD07			

<sup>(1)</sup> The algebraic convention, in which the least positive (most negative) limit is designated as minimum is used in this data sheet.

## **DRIVER ELECTRICAL CHARACTERISTICS**

over operating free-air temperature range unless otherwise noted (1)

PARAMETER		TEST CONDITIONS		MIN	TYP(1)	MAX	UNIT			
VIK	Input clamp voltage		I <sub>I</sub> = -18 mA		-1.5			V		
			No Load				VCC			
IVODI	Differential output voltage		$R_L$ = 54 Ω, See Figure 1		2.5			V		
			$V_{\text{test}} = -7 \text{ V to } 12 \text{ V}, \text{ See}$	Figure 2	2.2					
Δ VOD	Change in magnitude of dif output voltage	ferential	See Figure 1 and Figure 2		-0.2		0.2	V		
V <sub>OC</sub> (SS)	Steady-state common-mode output voltage				2.2		3.3	V		
ΔVOC(SS)	Change in steady-state common-mode output volta	ige	See Figure 3		See rigure 3		-0.1		0.1	V
	HVD05					600				
VOC(PP)	Peak-to-peak common- mode output voltage	HVD06	See Figure 3			500		mV		
, ,	\ / mode output voltage					900				
loz	High-impedance output cur	rent	See receiver input current	S						
i.	lanut aumant	D			-100		0	^		
l I	Input current	DE			0		100	μΑ		
los	Short-circuit output current		-7 V ≤ V <sub>O</sub> ≤ 12 V		-250		250	mA		
C <sub>(diff)</sub>	Differential output capacita	nce	$V_{ID} = 0.4 \sin(4E6\pi t) + 0.5$	5 V, DE at 0 V		16		pF		
, ,			RE at V <sub>CC</sub> , D & DE at V <sub>CC</sub> , No load	Receiver disabled and driver enabled		9	15	mA		
ICC Supply current			RE at V <sub>CC</sub> , D at V <sub>CC</sub> DE at 0 V, No load	Receiver disabled and driver disabled (standby)		1	5	μΑ		
			RE at 0 V, D & DE at V <sub>CC</sub> , No load	Receiver enabled and driver enabled		9	15	mA		

<sup>(1)</sup> All typical values are at 25°C and with a 5-V supply.

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## DRIVER SWITCHING CHARACTERISTICS NIL

over operating free-air temperature range unless otherwise noted

	PARAMETER		TEST CONDITIONS	MIN	TYP(1)	MAX	UNIT	
		HVD05			6.5	11		
tPLH	Propagation delay time, low-to-high-level output	HVD06			27	40	ns	
		HVD07			250	400		
		HVD05			6.5	11		
<sup>t</sup> PHL	Propagation delay time, high-to-low-level output	HVD06			27	40	ns	
		HVD07			250	400		
		HVD05	R <sub>L</sub> = 54 Ω,	2.7	3.6	6		
t <sub>r</sub>	Differential output signal rise time	HVD06	$C_{L} = 50 \text{ pF},$	18	28	55	ns	
		HVD07	See Figure 4	150	300	450		
		HVD05		2.7	3.6	6		
t <sub>f</sub>	Differential output signal fall time	HVD06		18	28	55	ns	
		HVD07		150	300	450		
		HVD05				2		
tsk(p)	Pulse skew ( tpHL - tpLH )					2.5	ns	
- (1)		HVD07				10		
		HVD05				3.5		
t <sub>sk(pp)</sub> (2)	(nn)(2) Part-to-part skew		1			14	ns	
- (11)		HVD07				100		
		HVD05				25		
<sup>t</sup> PZH1	Propagation delay time, high-impedance-to-high-level output	HVD06	1			45	ns	
		HVD07	RE at 0 V,			250		
		HVD05	$R_L = 110 \Omega$ , See Figure 5			25		
<sup>t</sup> PHZ	Propagation delay time, high-level-to-high-impedance output	HVD06				60	ns	
		HVD07				250		
		HVD05				15		
<sup>t</sup> PZL1	Propagation delay time, high-impedance-to-low-level output	HVD06	1			45	ns	
		HVD07	RE at 0 V,	200				
		HVD05	$R_L = 110 \Omega$ , See Figure 6			14		
t <sub>PLZ</sub>	Propagation delay time, low-level-to-high-impedance output	HVD06	guise			90	ns	
		HVD07	]			550		
<sup>t</sup> PZH2	Propagation delay time, standby-to-high-level output		$R_L = 110 \Omega$ , RE at 3 V, See Figure 5			6	μs	
<sup>t</sup> PZL2	Propagation delay time, standby-to-low-level output		$\frac{R_L}{RE}$ = 110 $\Omega$ , RE at 3 V, See Figure 6			6	μs	

 <sup>(1)</sup> All typical values are at 25°C and with a 5-V supply.
 (2) t<sub>sk(pp)</sub> is the magnitude of the difference in propagation delay times between any specified terminals of two devices when both devices operate with the same supply voltages, at the same temperature, and have identical packages and test circuits.



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## RECEIVER ELECTRICAL CHARACTERISTICS

over operating free-air temperature range unless otherwise noted

	PARAMETER			TEST CONDITIONS		MIN	TYP(1)	MAX	UNIT
VIT+	Positive-going input thr voltage	eshold	IO = -8 mA					-0.01	V
VIT-	Negative-going input the voltage	reshold	I <sub>O</sub> = 8 mA			-0.2			V
V <sub>hys</sub>	Hysteresis voltage (V <sub>I</sub>	r+ – VIT–)					35		mV
VIK	Enable-input clamp vol	tage	I <sub>I</sub> = -18 mA			-1.5			V
Vон	High-level output voltage	ge	$V_{ID} = 200 \text{ mV},$	$I_{OH} = -8 \text{ mA},$	See Figure 7	4			V
VOL	Low-level output voltag	e	$V_{ID} = -200 \text{ mV},$	I <sub>OL</sub> = 8 mA,	See Figure 7			0.4	V
loz	High-impedance-state current	output	VO = 0 or $VCC$	RE at V <sub>CC</sub>		-1		1	μΑ
				V <sub>A</sub> or V <sub>B</sub> = 12 V			0.23	0.5	
		10/505	Other input	$V_A$ or $V_B = 12 V$ ,	VCC = 0 V		0.3	0.5	
		HVD05	at 0 V	$V_A$ or $V_B = -7 V$		-0.4	-0.13		mA
		Due input compart		$V_A$ or $V_B = -7 V$ ,	VCC = 0 V	-0.4	-0.15		
11	Bus input current			$V_A$ or $V_B = 12 V$			0.06	0.1	
		HVD06,	Otherinput	$V_A$ or $V_B = 12 V$ ,	VCC = 0 V		0.08	0.13	mA
		HVD07	at 0 V	$V_A$ or $V_B = -7 V$		-0.1	-0.05		
				$V_A$ or $V_B = -7 V$ ,	VCC = 0 V	-0.05	-0.03		
lн	High-level input curren	t, RE	V <sub>IH</sub> = 2 V			-60	-26.4		μΑ
Ι <sub>Ι</sub>	Low-level input current	, RE	V <sub>IL</sub> = 0.8 V			-60	-27.4		μΑ
C <sub>(diff)</sub>	Differential input capac	itance	V <sub>I</sub> = 0.4 sin (4E6	πt) + 0.5 V, DE at 0	V		16		pF
			RE at 0 V, D & DE at 0 V, No load	Receiver enabled a	nd driver disabled		5	10	mA
Icc	I <sub>CC</sub> Supply current		RE at V <sub>CC</sub> , DE at 0 V, D at V <sub>CC</sub> , No load	Receiver disabled a (standby)	nd driver disabled		1	5	μΑ
			RE at 0 V, D & DE at V <sub>CC</sub> , No load	Receiver enabled a	nd driver enabled		9	15	mA

<sup>(1)</sup> All typical values are at 25°C and with a 5-V supply.

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## RECEIVER SWITCHING CHARACTERISTICS

over operating free-air temperature range unless otherwise noted

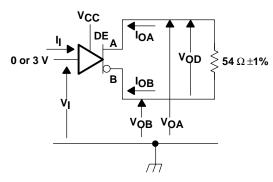
	PARAMETER		TEST CONDITIONS	MIN TYP(1)	MAX	UNIT
<sup>t</sup> PLH	Propagation delay time, low-to-high-level output 1/2 UL	HVD05		14.6	25	ns
<sup>t</sup> PHL	Propagation delay time, high-to-low-level output 1/2 UL	HVD05		14.6	25	ns
4	Dranagation delevitime law to high level output 4/0 LII	HVD06		55	70	20
<sup>t</sup> PLH	Propagation delay time, low-to-high-level output 1/8 UL	HVD07	$V_{ID} = -1.5 \text{ V to } 1.5 \text{ V},$	55	70	ns
	Depression delections high to level out out 4/0111	HVD06	C <sub>L</sub> = 15 pF,	55	70	
<sup>t</sup> PHL	Propagation delay time, high-to-low-level output 1/8 UL	HVD07	See Figure 8	55	70	ns
		HVD05			2	
tsk(p)	Pulse skew ( tpHL - tpLH )				4.5	ns
",		HVD07			4.5	
		HVD05			6.5	
tsk(pp)(2)	Part-to-part skew	HVD06			14	ns
"",		HVD07			14	
t <sub>r</sub>	Output signal rise time		C <sub>L</sub> = 15 pF,	2	3	
tf	Output signal fall time		See Figure 8	2	3	ns
<sup>t</sup> PZH1	Output enable time to high level				10	
tPZL1			C <sub>L</sub> = 15 pF,		10	
tPHZ			DE at 3 V, See Figure 9		15	ns
tPLZ	tPLZ Output disable time from low level		3		15	
tPZH2	PZH2 Propagation delay time, standby-to-high-level output		C <sub>I</sub> = 15 pF, DE at 0,		6	
tPZL2	Propagation delay time, standby-to-low-level output		See Figure 10		6	μs

<sup>(1)</sup> All typical values are at 25°C and with a 5-V supply.

<sup>(2)</sup> t<sub>sk(pp)</sub> is the magnitude of the difference in propagation delay times between any specified terminals of two devices when both devices operate with the same supply voltages, at the same temperature, and have identical packages and test circuits.



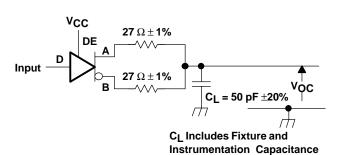
#### PARAMETER MEASUREMENT INFORMATION

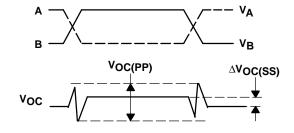


0 or 3 V DE A VOD 60 Ω±1% +-7 V < V(test) 375 Ω±1%

Figure 1. Driver V<sub>OD</sub> Test Circuit and Voltage and Current Definitions

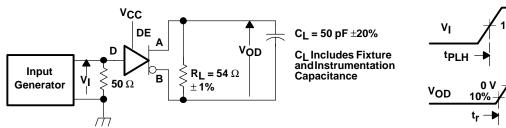
Figure 2. Driver V<sub>OD</sub> With Common-Mode Loading Test Circuit

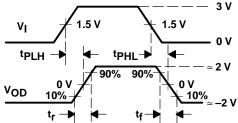




Input: PRR = 500 kHz, 50% Duty Cycle, $t_{\Gamma}$ <6ns,  $t_{f}$ <6ns,  $Z_{O}$  = 50  $\Omega$ 

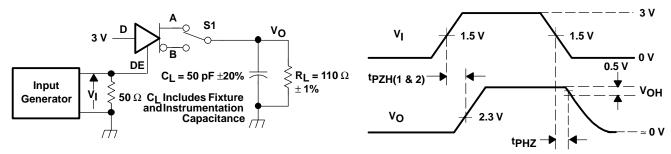
Figure 3. Test Circuit and Definitions for the Driver Common-Mode Output Voltage





Generator: PRR = 500 kHz, 50% Duty Cycle,  $t_r$  <6 ns,  $t_f$  <6 ns,  $Z_0$  = 50  $\Omega$ 

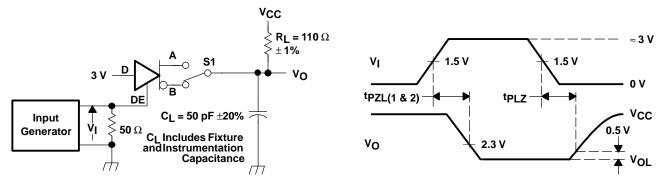
Figure 4. Driver Switching Test Circuit and Voltage Waveforms



Generator: PRR = 100 kHz, 50% Duty Cycle,  $t_{\Gamma}$  <6 ns,  $t_{f}$  <6 ns,  $Z_{O}$  = 50  $\Omega$ 

Figure 5. Driver High-Level Enable and Disable Time Test Circuit and Voltage Waveforms





Generator: PRR = 100 kHz, 50% Duty Cycle,  $t_{\Gamma}$  <6 ns,  $t_{f}$  <6 ns,  $Z_{O}$  = 50  $\Omega$ 

Figure 6. Driver Low-Level Output Enable and Disable Time Test Circuit and Voltage Waveforms

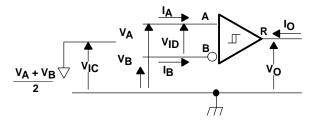


Figure 7. Receiver Voltage and Current Definitions

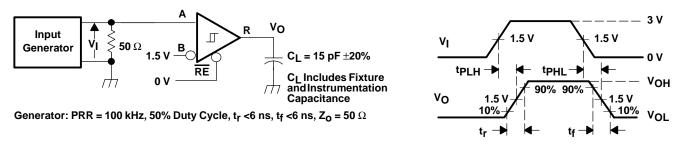


Figure 8. Receiver Switching Test Circuit and Voltage Waveforms



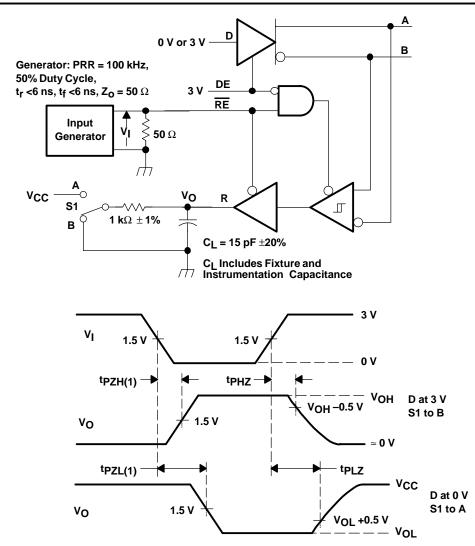
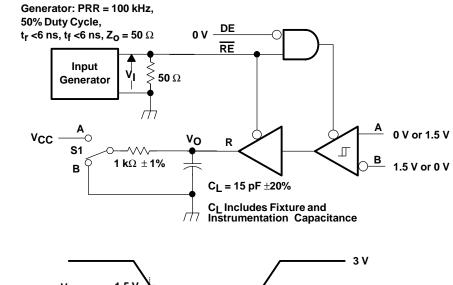


Figure 9. Receiver Enable and Disable Time Test Circuit and Voltage Waveforms With Drivers Enabled





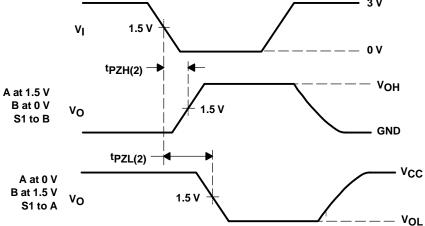
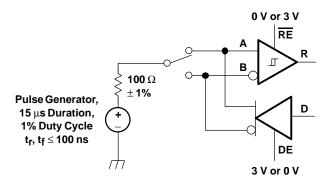
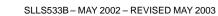


Figure 10. Receiver Enable Time From Standby (Driver Disabled)



NOTE: This test is conducted to test survivability only. Data stability at the R output is not specified.

Figure 11. Test Circuit, Transient Over Voltage Test





## **FUNCTION TABLES**

#### DRIVER

INPUT	ENABLE	OUT	PUTS
D	DE	Α	В
Н	Н	Н	L
L	Н	L	Н
X	L	Z	Z
Open	Н	Н	L
Х	Open	Z	Z

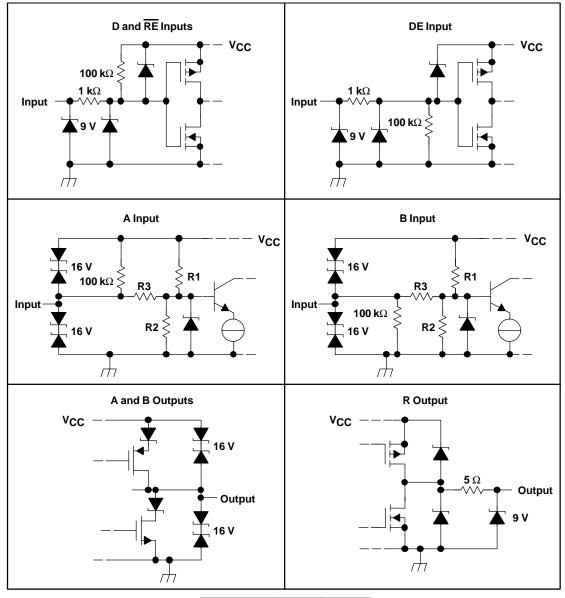
#### **RECEIVER**

DIFFERENTIAL INPUTS	ENABLE	OUTPUT
$V_{ID} = V_A - V_B$	RE	R
V <sub>ID</sub> ≤ -0.2 V	L	L
$-0.2 \text{ V} < \text{V}_{\text{ID}} < -0.01 \text{ V}$	L	?
-0.01 V ≤ V <sub>ID</sub>	L	Н
X	Н	Z
Open Circuit	L	Н
Short Circuit	L	Н
X	Open	Z

 $H = high\ level; \quad L = low\ level; \quad Z = high\ impedance; \quad X = irrelevant; \\ ? = indeterminate$ 



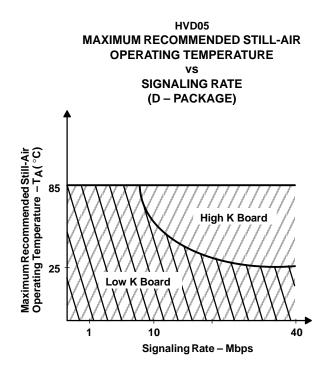
## **EQUIVALENT INPUT AND OUTPUT SCHEMATIC DIAGRAMS**



	R1/R2	R3
SN65HVD05	9 kΩ	<b>45 k</b> Ω
SN65HVD06	<b>36 k</b> Ω	<b>180 k</b> Ω
SN65HVD07	<b>36 k</b> Ω	<b>180 k</b> Ω



#### TYPICAL CHARACTERISTICS



HYD06

MAXIMUM RECOMMENDED STILL-AIR
OPERATING TEMPERATURE

VS
SIGNALING RATE
(D - PACKAGE)

High K Board

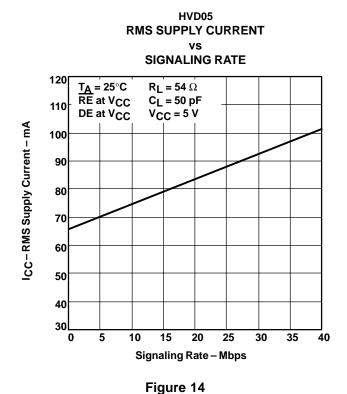
Low K Board

Signaling Rate - Mbps

Figure 12

Figure 13

HVD06



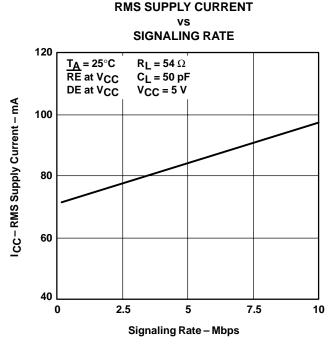


Figure 15





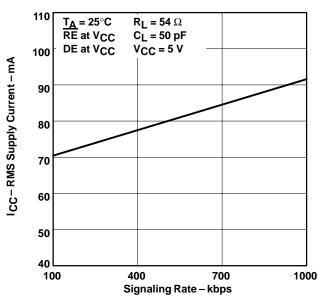


Figure 16

# BUS INPUT CURRENT vs BUS INPUT VOLTAGE

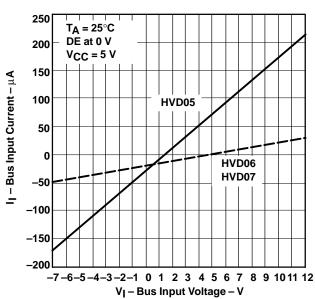


Figure 17

# DRIVER HIGH-LEVEL OUTPUT CURRENT vs HIGH-LEVEL OUTPUT VOLTAGE

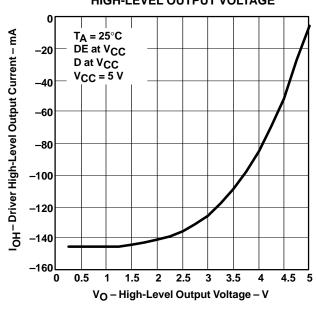


Figure 18

# DRIVER LOW-LEVEL OUTPUT CURRENT vs LOW-LEVEL OUTPUT VOLTAGE

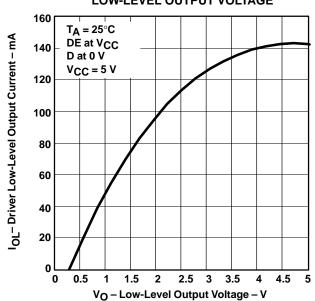
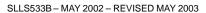
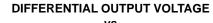
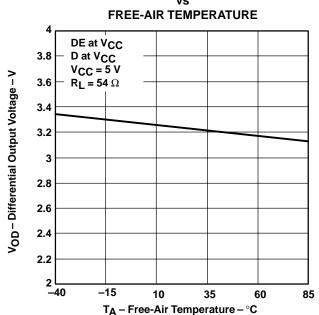


Figure 19









DRIVER OUTPUT CURRENT
vs
SUPPLY VOLTAGE

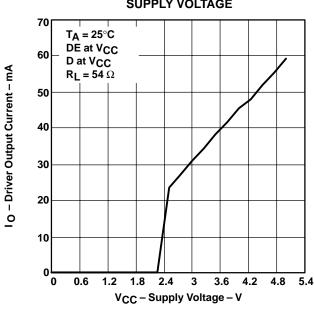


Figure 20 Figure 21

# DIFFERENTIAL OUTPUT VOLTAGE vs DIFFERENTIAL OUTPUT CURRENT

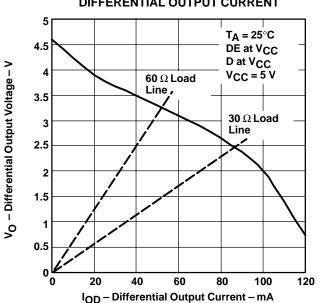
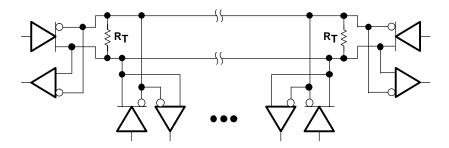


Figure 22



## **APPLICATION INFORMATION**



Device	Number of Devices on Bus
HVD05	64
HVD06	256
HVD07	256

NOTE: The line should be terminated at both ends with its characteristic impedance ( $R_T = Z_O$ ). Stub lengths off the main line should be kept as short as possible.

Figure 23. Typical Application Circuit

#### P (R-PDIP-T8)

#### PLASTIC DUAL-IN-LINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MS-001

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# D (R-PDSO-G8)

# PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-012 variation AA.



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